

General Description

The WST2300 is the highest performance trench N-Ch MOSFET with extreme high cell density , which provide excellent R_{DSON} and gate charge for most of the small power switching and load switch applications.

The WST2300 meet the RoHS and Green Product requirement with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

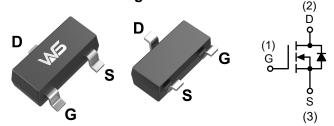
Product Summery

BV _{DSS}	R _{DSON}	I _D
20V	19mΩ	6.1A

Applications

- High Frequency Point-of-Load Synchronous s Small power switching for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

SOT-23L Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units	
V_{DS}	Drain-Source Voltage	20	V	
V_{GS}	Gate-Source Voltage	±12	V	
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 4.5V ¹	6.1	А	
I _D @T _C =70°C	Continuous Drain Current, V _{GS} @ 4.5V ¹	4.5	А	
I _{DM}	Pulsed Drain Current ²	12	А	
P _D @T _A =25℃	Total Power Dissipation ³	1.0	W	
T _{STG}	Storage Temperature Range	-55 to 150	$^{\circ}$	
T _J	Operating Junction Temperature Range	-55 to 150	$^{\circ}$	

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient ¹		200	°C/W
$R_{ heta JC}$	Thermal Resistance Junction-Case ¹		75	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	20			V
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25℃ , I _D =1mA		0.024		V/°C
	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =6.1A		19	25	mΩ
R _{DS(ON)}		V _{GS} =2.5V , I _D =4.5A		25	35	
		V _{GS} =1.8V , I _D =1A -		-		
$V_{GS(th)}$	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	0.3	0.85	1.2	٧
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	V _{GS} -V _{DS} , I _D -2500A		-2.51		mV/℃
	Drain Source Loakage Current	V _{DS} =16V , V _{GS} =0V , T _J =25℃			1	
I _{DSS}	Drain-Source Leakage Current	V_{DS} =16V , V_{GS} =0V , T_J =55 $^{\circ}$ C			5	· uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 8V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V_{DS} =5V , I_D =3A		8.3		S
R_g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.7	3.4	Ω
Q_g	Total Gate Charge (4.5V)			6.4		
Q_gs	Gate-Source Charge	V_{DS} =15V , V_{GS} =4.5V , I_{D} =1A		0.54		nC
Q_gd	Gate-Drain Charge			1.25		
T _{d(on)}	Turn-On Delay Time			1.6		
Tr	Rise Time	V_{DD} =10V , V_{GS} =4.5V , R_{G} =3.3 Ω		29.6		20
T _{d(off)}	Turn-Off Delay Time			6		ns
T _f	Fall Time			18.8		
Ciss	Input Capacitance			382		
C _{oss}	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		41		pF
C _{rss}	Reverse Transfer Capacitance			33		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
I _S	Continuous Source Current ^{1,4}	V =V =0V Force Current			6.1	Α
I _{SM}	Pulsed Source Current ^{2,4}	V _G =V _D =0V , Force Current			12	Α
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25℃			1.2	V
t _{rr}	Reverse Recovery Time			5.5		nS
Qrr	Reverse Recovery Charge	IF=2A , dI/dt=100A/ μ s , T $_{J}$ =25 $^{\circ}$ C		1.8		nC

Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper ,t<10sec.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3.The power dissipation is limited by 150 $^{\circ}\mathrm{C}$ junction temperature
- 4. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

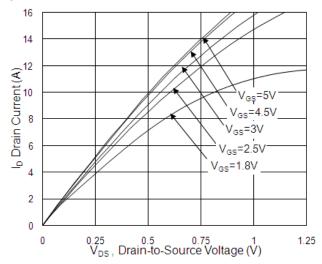


Fig.1 Typical Output Characteristics

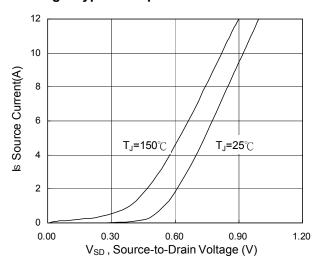


Fig.3 Forward Characteristics Of Reverse

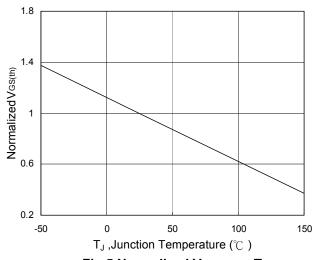


Fig.5 Normalized $V_{\text{GS(th)}}$ vs. T_{J}

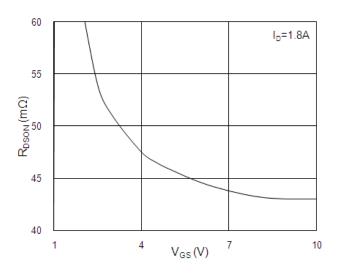


Fig.2 On-Resistance vs. Gate-Source

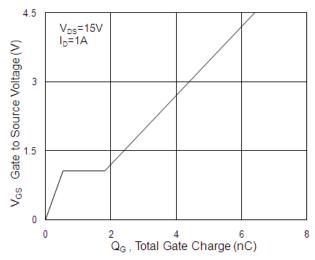


Fig.4 Gate-Charge Characteristics

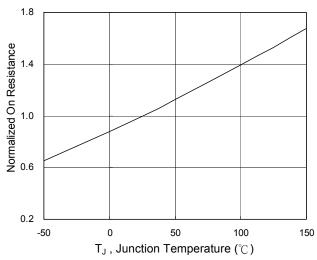
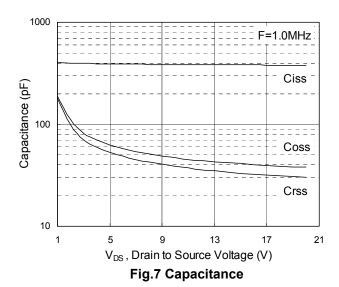


Fig.6 Normalized R_{DSON} vs. T_{J}





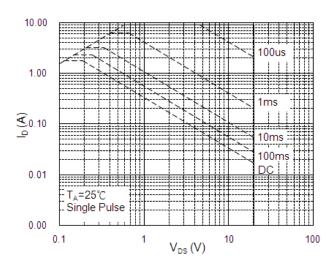


Fig.8 Safe Operating Area

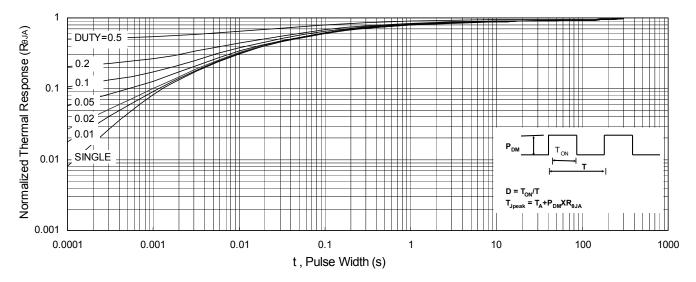
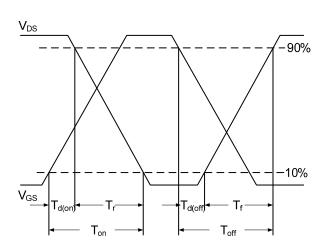


Fig.9 Normalized Maximum Transient Thermal Impedance



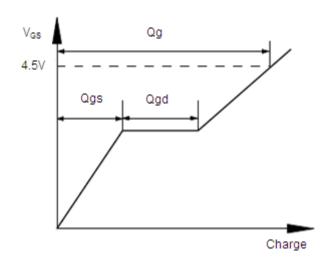
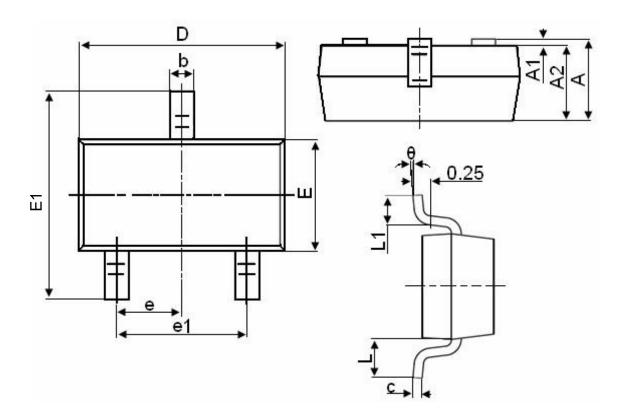


Fig.10 Switching Time Waveform

Fig.11 Gate Charge Waveform



Packaging information



Comple of	Dimensions in Millimeters			
Symbol	MIN.	MAX.		
Α	0.900	1.150		
A1	0.000	0.100		
A2	0.900	1.050		
b	0.300	0.500		
С	0.080	0.150		
D	2.800	3.000		
Е	1.200	1.400		
E1	2.250	2.550		
е	0.99	0.950TYP		
e1	1.800	2.000		
L	0.550REF			
L1	0.300	0.500		
θ	0°	8°		



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